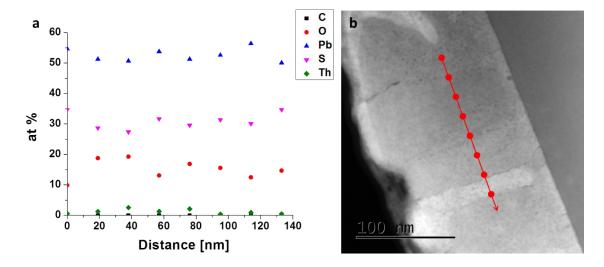
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## **Electronic Supplementary Information**

## **Enhanced SWIR Absorption in Chemical Bath Deposited PbS Thin Films Alloyed with Thorium and Oxygen**

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**Figure SI 1.** (a) Atomic composition plotted as a function of film position (b) HAADF STEM X-TEM micrograph of PbS film containing 1at% Th. Red dots depict the EDS line scan performed.

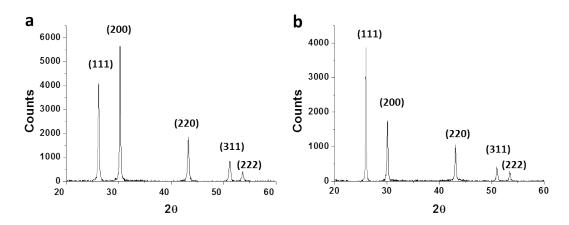
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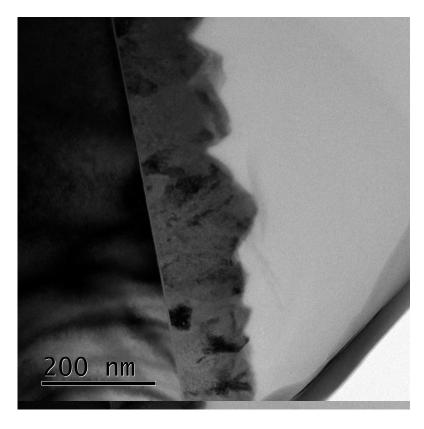
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**Figure SI 2.** Normalized diffractograms taken from films grown on glass substrates, (a) PbS and (b) PbS(Th,O).



**Figure SI 3.** Bright field X-TEM micrograph of a PbS(Th,O) film with a composition of 8.1at% Th.